

# Chapter 3

## Solution Manual

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### 3.1:

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Vegard's law states that for an alloy of two compounds  $XZ$  and  $YZ$  with concentrations defined by  $X_xY_{1-x}Z$ , the lattice parameter  $a(x)$  as a function of alloy concentration  $x$  is defined by:

$$a(x) = xa(XZ) + (1 - x)a(YZ) \quad (1)$$

where  $a(XZ)$  and  $a(YZ)$  are the lattice parameters of  $XZ$  and  $YZ$  respectively.

To lattice match  $Ga_xIn_{1-x}P$  and  $GaAs$ , we have the condition:

$$5.6533 = x(5.4505) + (1 - x)(5.8688) \rightarrow x = 0.5152 \quad (2)$$

To lattice match  $Ga_xIn_{1-x}As$  and  $InP$ , we have the condition:

$$5.8688 = x(5.6533) + (1 - x)(6.0584) \rightarrow x = 0.468 \quad (3)$$

To produce a compressive strain of  $\frac{a(GaInAs) - a(InP)}{a(InP)} = 0.01$ , we have the condition:

$$0.01 = \frac{x(5.6533) + (1 - x)(6.0584) - 5.8688}{5.8688} \rightarrow x = 0.3232 \quad (4)$$

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### 3.2:

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Using the formula given, the bandgap of  $Ga_{.5152}In_{.4848}P$  is given by:

$$E_g^{GaInP} = 1.35 + 0.73(.5152) + 0.7(.5152)^2 = 1.912eV \quad (5)$$

The band offset ratios for typical III-V compounds are:

$$\frac{\Delta E_c}{\Delta E_g} = 0.66 \quad \text{and} \quad \frac{\Delta E_v}{\Delta E_g} = 0.34 \quad (6)$$

Since the bandgap of  $GaAs$  is  $E_g^{GaAs} = 1.424eV$ , the conduction and valence band offsets are given by:

$$\Delta E_c \approx 0.66(1.912 - 1.424) = 0.322eV \quad (7)$$

$$\Delta E_v \approx 0.34(1.912 - 1.424) = 0.166eV \quad (8)$$

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**3.3:**

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The lattice constants of *Ge* and *GaAs* are 5.6579Å and 5.6533Å respectively. The strain of a *Ge* layer on a *GaAs* substrate is thus:

$$\frac{a(Ge) - a(GaAs)}{a(GaAs)} = 8.1368 \times 10^{-4} \quad (9)$$

The lattice constants of *Ge* and *GaAs* are matched very well, resulting in a very small strain in the *Ge* layer. So at least in terms of minimizing non-radiative recombination due to dislocations and defects, it is an excellent heterostructure for light-emission.

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**3.4:**

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We first note that the lattice constants for  $In_{1-y}Al_yAs$  and  $In_{1-x}Ga_xAs$  are given by:

$$a(In_{1-x}Ga_xAs) = x(5.6533) + (1-x)(6.0584) \quad a(In_{1-y}Al_yAs) = y(5.66) + (1-y)(6.0584) \quad (10)$$

To lattice-match with *InP*, we have the condition:

$$5.8688 = za(InAlAs) + (1-z)a(InGaAs) \quad (11)$$

To lattice match for all values of  $z$ , we require:

$$a(InAlAs) = a(InGaAs) = 5.8688 \quad (12)$$

or explicitly in terms of the expressions above:

$$5.8688 = x(5.6533) + (1-x)(6.0584) \rightarrow x = 0.468 \quad (13)$$

$$5.8688 = y(5.66) + (1-y)(6.0584) \rightarrow y = 0.4759 \quad (14)$$

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**3.5:**

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The *InAlGaAs* compound in problem (3.4) has a lattice constant of 5.8688. The relative concentration in lattice-matched *InGaAs* is found to be:

$$5.8688 = xa(GaAs) + (1-x)a(InAs) \rightarrow x = 0.468 \quad (15)$$

Assuming the bandgap is a linear function of the lattice constant in *InGaAs*, the bandgap of the above compound is, according to Vegard's law:

$$E_g^{InGaAs} = (0.468)E_g^{GaAs} + (1-0.468)E_g^{InAs} = 0.85476eV \quad (16)$$

From the band offset ratio  $\frac{\Delta E_c}{\Delta E_g} = 0.66$ , we find:

$$\Delta E_g = \frac{0.2}{0.66} = 0.303eV \quad (17)$$

which gives a *InAlGaAs* bandgap of  $E_g^{InAlGaAs} = \Delta E_g + E_g^{InGaAs} = 1.1578eV$ . This corresponds to a composition  $z$  of:

$$1.1578 = 0.76 + 0.49z + 0.20z^2 \rightarrow z = 0.643 \quad (18)$$